

HEARING AID COMPATIBILITY

Applicant Name:

LG Electronics U.S.A, Inc.
1000 Sylvan Avenue
Englewood Cliffs, NJ 07632
United States

Date of Testing:

10/29/2018 - 10/31/2018

Test Site/Location:

PCTEST Lab, Columbia, MD, USA

Test Report Serial No.:

1M1810290199-02-R2.ZNF

FCC ID:

ZNFX212TA

APPLICANT:

LG ELECTRONICS U.S.A, INC.

Scope of Test:

Audio Band Magnetic Testing (T-Coil)

Application Type:

Class II Permissive Change

FCC Rule Part(s):

CFR §20.19(b)

HAC Standard:

ANSI C63.19-2011

285076 D01 HAC Guidance v05

285076 D02 T-Coil testing for CMRS IP v03

DUT Type:

Portable Handset

Model:

LM-X220MA

Additional Model(s):

LMX220MA, X220MA

Test Device Serial No.:

Pre-Production Sample [S/N: 02819]

Class II Permissive Change(s):

See FCC Change Document

Original Grant Date:

03/28/2018

C63.19-2011 HAC Category: **T3 (SIGNAL TO NOISE CATEGORY, LTE B25 & B26 Only)**

Note: This revised Test Report (S/N: 1M1810290199-02-R2.ZNF) supersedes and replaces the previously issued test report on the same subject device for the same type of testing as indicated. Please discard or destroy the previously issued test report(s) and dispose of it accordingly.

This report and category pertain only to LTE bands 26 & 25 supported by this wireless portable device. The overall category rating of the device is determined by the lowest rating obtained over all air interfaces supported by the device. This wireless portable device has been shown to be hearing-aid compatible under the above rated category, specified in ANSI/IEEE Std. C63.19-2011 and has been tested in accordance with the specified measurement procedures. Test results reported herein relate only to the item(s) tested. Hearing-Aid Compatibility is based on the assumption that all production units will be designed electrically identical to the device tested in this report. North American Bands only.

I attest to the accuracy of data. All measurements reported herein were performed by me or were made under my supervision and are correct to the best of my knowledge and belief. I assume full responsibility for the completeness of these measurements and vouch for the qualifications of all persons taking them.


Randy Ortanez
President



FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 1 of 42

T A B L E O F C O N T E N T S

1.	INTRODUCTION	3
2.	DUT DESCRIPTION.....	4
3.	ANSI C63.19-2011 PERFORMANCE CATEGORIES	5
4.	METHOD OF MEASUREMENT	7
5.	OTT VOIP TEST SYSTEM AND DUT CONFIGURATION	16
6.	T-COIL TEST SUMMARY	17
7.	MEASUREMENT UNCERTAINTY	21
8.	EQUIPMENT LIST.....	22
9.	TEST DATA.....	23
10.	CALIBRATION CERTIFICATES.....	30
11.	CONCLUSION.....	37
12.	REFERENCES	38
13.	TEST SETUP PHOTOGRAPHS	40

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 2 of 42

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1. INTRODUCTION

On July 10, 2003, the Federal Communications Commission (FCC) adopted new rules requiring wireless manufacturers and service providers to provide digital wireless phones that are compatible with hearing aids. The FCC has modified the exemption for wireless phones under the Hearing Aid Compatibility Act of 1998 (HAC Act) in WT Docket 01-309 RM-8658¹ to extend the benefits of wireless telecommunications to individuals with hearing disabilities. These benefits encompass business, social and emergency communications, which increase the value of the wireless network for everyone. An estimated more than 10% of the population in the United States show signs of hearing impairment and of that fraction, almost 80% use hearing aids. Approximately 500 million people worldwide and 30 million people in the United States suffer from hearing loss.

Compatibility Tests Involved:

The standard calls for wireless communications devices to be measured for:

- RF Electric-field emissions
- T-coil mode, magnetic-signal strength in the audio band
- T-coil mode, magnetic-signal frequency response through the audio band
- T-coil mode, magnetic-signal and noise articulation index

The hearing aid must be measured for:

- RF immunity in microphone mode
- RF immunity in T-coil mode

In the following tests and results, this report includes the evaluation for a wireless communications device.

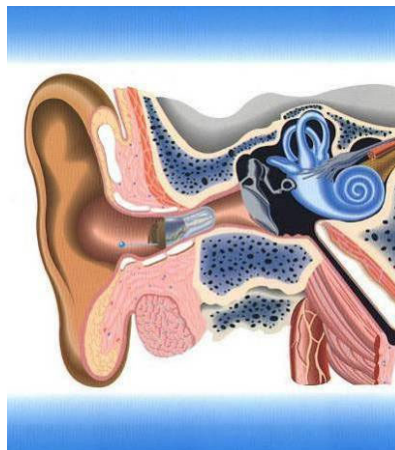


Figure 1-1 Hearing Aid *in-vitu*

¹ FCC Rule & Order, WT Docket 01-309 RM-8658

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 3 of 42

2. DUT DESCRIPTION



FCC ID: ZNFX212TA
 Applicant: LG Electronics U.S.A, Inc.
 1000 Sylvan Avenue
 Englewood Cliffs, NJ 07632
 United States
 Model: LM-X220MA
 Additional Model(s): LMX220MA, X220MA
 Serial Number: 02819
 HW Version: Rev.1.0
 SW Version: X220MA8i
 Antenna: Internal Antenna
 DUT Type: Portable Handset

Table 2-1
ZNFX212TA HAC Air Interfaces

Air-Interface	Band (MHz)	Type Transport	HAC Tested	Simultaneous But Not Tested	Name of Voice Service	Audio Codec Evaluated
GSM	850	VO	No ³	Yes: WIFI or BT	CMRS Voice ¹	EFR
	1900					
	GPRS/EDGE	VD	No ³	Yes: WIFI or BT	Google Duo ²	OPUS
UMTS	850	VD	No ³	Yes: WIFI or BT	CMRS Voice ¹	NB AMR
	1700					
	1900					
	HSPA	VD	No ³	Yes: WIFI or BT	Google Duo ²	OPUS
LTE (FDD)	680 (B71)	VD	No ³	Yes: WIFI or BT	VoLTE ¹ , Google Duo ²	VoLTE: NB AMR, WB AMR Google Duo: OPUS
	700 (B12)					
	850 (B5)		Yes			
	850 (B26)		No ³			
	1700 (B4)					
	1700 (B66)					
	1900 (B2)		Yes			
	1900 (B25)					
WIFI	2450	VD	No ³	Yes: GSM, UMTS, or LTE	VoWIFI ² , Google Duo ²	VoWIFI: NB AMR, WB AMR Google Duo: OPUS
	5200 (U-NII 1)					
	5300 (U-NII 2A)					
	5500 (U-NII 2C)					
	5800 (U-NII 3)					
BT	2450	DT	No	Yes: GSM, UMTS, or LTE	N/A	N/A
Type Transport VO = Voice Only DT = Digital Data - Not intended for CMRS Service VD = CMRS and IP Voice over Data Transport			Notes: ¹ Reference level in accordance with 7.4.2.1 of ANSI C63.19-2011 and July 2012 C63 VoLTE Interpretation. ² Reference level is -20dBm0 in accordance with FCC KDB 285076 D02 ³ This report only pertains to LTE Band 25 & 26 for VoLTE and Google Duo. For full data, please refer to the previous Certification Test Report (RFE Test Report S/N: 1M1802060016-10.ZNF).			

FCC ID: ZNFX212TA	PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	LG	Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset	Page 4 of 42	

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04/17/2018

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3. ANSI C63.19-2011 PERFORMANCE CATEGORIES

I. MAGNETIC COUPLING

Axial and Radial Field Intensity

All orientations of the magnetic field, in the axial and radial position along the measurement plane shall be ≥ -18 dB(A/m) at 1 kHz in a 1/3 octave band filter per §8.3.1.

Frequency Response

The frequency response of the axial component of the magnetic field shall follow the response curve specified in EIA RS-504-1983, over the frequency range 300 Hz – 3000 Hz per §8.3.2.

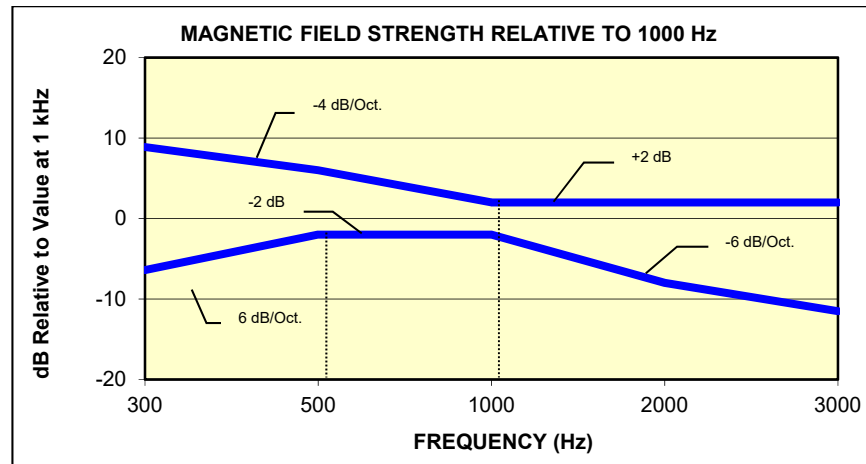


Figure 3-1
Magnetic field frequency response for Wireless Devices with an axial field ≤ -15 dB(A/m) at 1 kHz

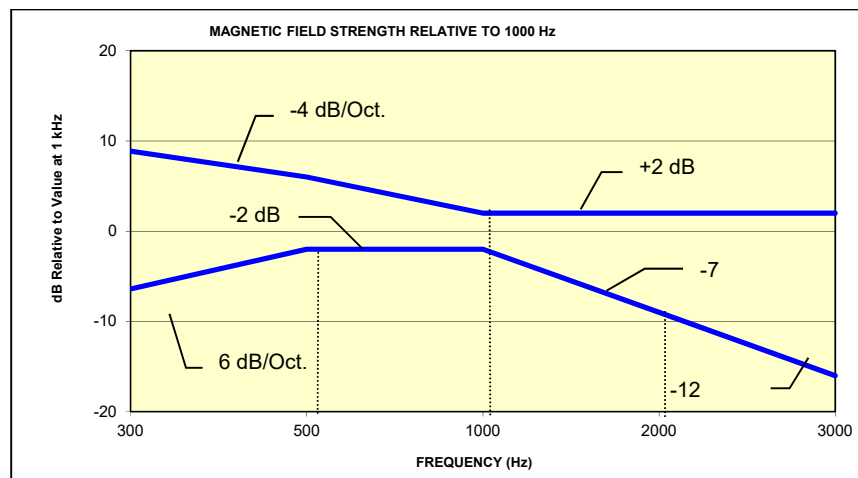


Figure 3-2
Magnetic Field frequency response for wireless devices with an axial field that exceeds -15 dB(A/m) at 1 kHz

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 5 of 42

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REV 3.2.M

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Signal Quality

The table below provides the signal quality requirement for the intended audio magnetic signal from a wireless device. Only the RF immunity of the hearing aid is measured in T-coil mode. It is assumed that a hearing aid can have no immunity to an interference signal in the audio band, which is the intended reception band for this mode. The only criterion that can be measured is the RF immunity in T-coil mode. This is measured using the same procedure as the audio coupling mode at the same levels.

The signal quality of the axial and radial components of the magnetic field was used to determine the T-coil mode category.

Category	Telephone RF Parameters
	Wireless Device Signal Quality [(Signal + Noise)-to-noise ratio in dB]
T1	0 to 10 dB
T2	10 to 20 dB
T3	20 to 30 dB
T4	> 30 dB

Table 3-1
Magnetic Coupling Parameters

Note: The FCC limit for SNNR is 20dB and the test data margins will indicate a margin from the FCC limit for compliance.

FCC ID: ZNFX212TA	 PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	 LG	Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 6 of 42

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04/17/2018

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4. METHOD OF MEASUREMENT

I. Test Setup

The equipment was connected as shown in an acoustic/RF hemi-anechoic chamber:

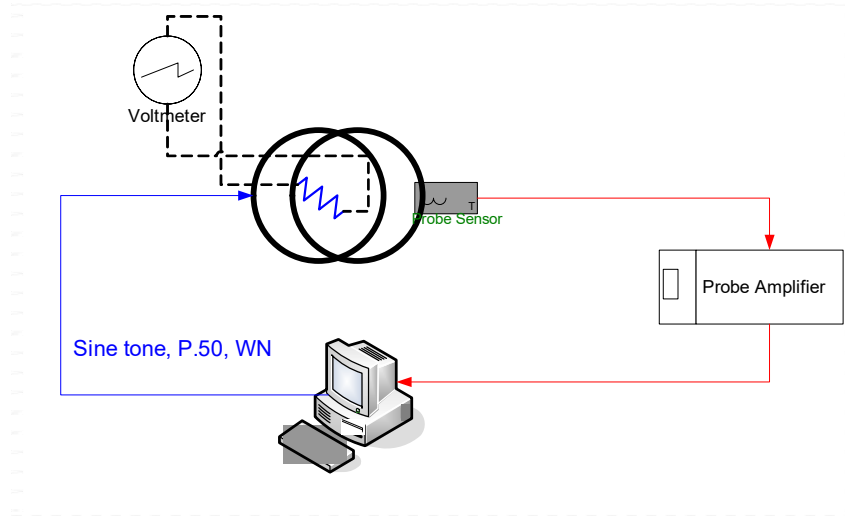


Figure 4-1
Validation Setup with Helmholtz Coil

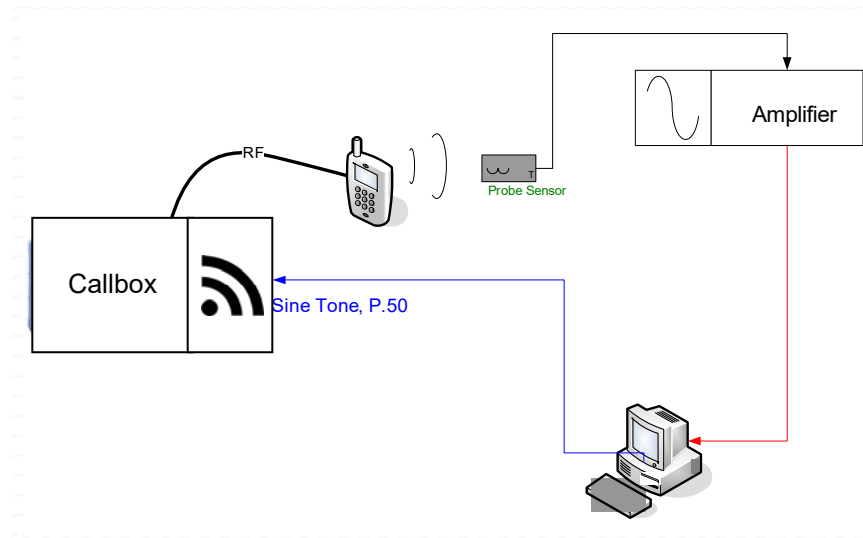


Figure 4-2
T-Coil Test Setup

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 7 of 42

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REV 3.2.M

04/17/2018

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II. Scanning Mechanism

Manufacturer:	TEM
Accuracy:	± 0.83 cm/meter
Minimum Step Size:	0.1 mm
Maximum speed	6.1 cm/sec
Line Voltage:	115 VAC
Line Frequency:	60 Hz
Material Composite:	Delrin (Acetal)
Data Control:	Parallel Port
Dynamic Range (X-Y-Z):	45 x 31.75 x 47 cm
Dimensions:	36" x 25" x 38"
Operating Area:	36" x 49" x 55"
Reflections:	< -20 dB (in anechoic chamber)

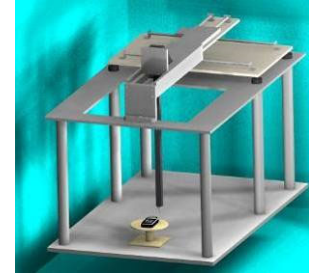


Figure 4-3
RF Near-Field Scanner

III. ITU-T P.50 Artificial Voice

Manufacturer:	ITU-T
Active Frequency Range:	100 Hz – 8 kHz
Stimulus Type:	Male and Female, no spaces
Single Sample Duration:	20.96 seconds
Activity Level:	100%

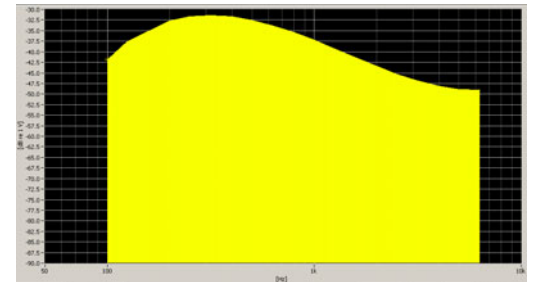


Figure 4-4
Spectral Characteristic of full P.50

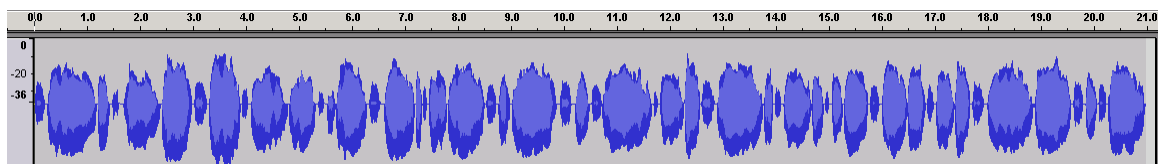
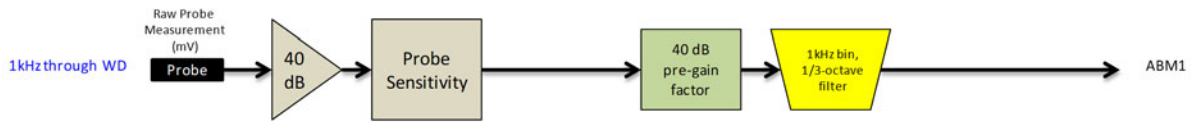


Figure 4-5
Temporal Characteristic of full P.50

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 8 of 42

ABM1 Measurement Block Diagram:



ABM2 Measurement Block Diagram:

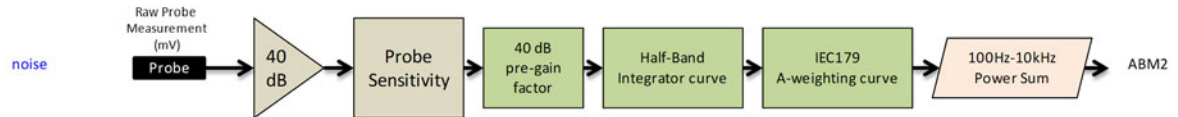


Figure 4-6 Magnetic Measurement Processing Steps

IV. Test Procedure

1. Ambient Noise Check per C63.19 §7.3.1
 - a. Ambient interference was monitored using a Real-Time Analyzer between 100-10,000 Hz with 1/3 octave filtering.
 - b. “A-weighting” and Half-Band Integration was applied to the measurements.
 - c. Since this measurement was measured in the same method as ABM2 measurements, this level was verified to be more than 10 dB below the lowest measurement signal (which is the highest ABM2 measurement for a T4 WD). Therefore the maximum noise level for a T4 WD with an ABM1 = -18 dBA/m is:

$$-18 - 30 - 10 = -58 \text{ dBA/m}$$
2. Measurement System Validation(See Figure 4-1)
 - a. The measurement system including the probe, pre-amplifier and acquisition system were validated as an entire system to ensure the reliability of test measurements.
 - b. ABM1 Validation
 The magnetic field at the center of the Helmholtz coil is given by the equation (per C63.19 Annex D.10.1):

$$H_c = \frac{NI}{r\sqrt{1.25^3}} = \frac{N(\frac{V}{R})}{r\sqrt{1.25^3}}$$

Where H_c = magnetic field strength in amperes per meter

N = number of turns per coil

For the Helmholtz Coil, N=20; r=0.08m; R=10.2Ω and using V=18mV:

$$H_c = \frac{20 \cdot (\frac{0.018}{10.2})}{0.08 \cdot \sqrt{1.25^3}} = 0.316 \text{ A/m} \approx -10 \text{ dB(A/m)}$$

Therefore a pure tone of 1kHz was applied into the coils such that 18mV was observed across the resistor. The voltmeter used for measurement was verified to be capable of measurements in the audio band range. This theoretically generates an expected field of -10 dB(A/m) in the center of the Helmholtz coil which was used to validate the probe measurement at -10dB(A/m). This was verified to be within ± 0.5 dB of the -10dB(A/m) value (see Page 19).

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 9 of 42

c. Frequency Response Validation

The frequency response through the Helmholtz Coil was verified to be within 0.5 dB relative to 1kHz, between 300 – 3000 Hz using the P.50 signal as shown below:

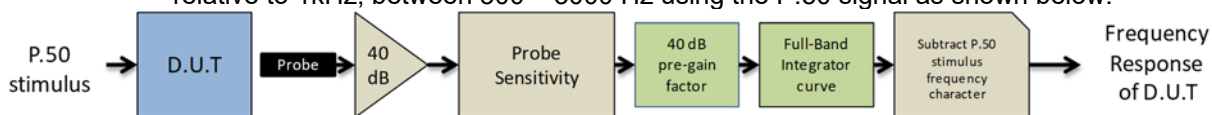


Figure 4-7 Frequency Response Validation

d. ABM2 Measurement Validation

WD noise measurements are filtered with A-weighting and Half-Band Integration over a frequency range of 100Hz – 10kHz to process ABM2 measurements. Below is the verification of the system processing A-weighting and Half-Band integration between system input to output within 0.5 dB of the theoretical result:

**Table 4-1
ABM2 Frequency Response Validation**

f (Hz)	HBI, A - Measured (dB re 1kHz)	HBI, A - Theoretical (dB re 1kHz)	dB Var.
100	-16.180	-16.170	-0.010
125	-13.257	-13.250	-0.007
160	-10.347	-10.340	-0.007
200	-8.017	-8.010	-0.007
250	-5.925	-5.920	-0.005
315	-4.045	-4.040	-0.005
400	-2.405	-2.400	-0.005
500	-1.212	-1.210	-0.002
630	-0.349	-0.350	0.001
800	0.071	0.070	0.001
1000	0.000	0.000	0.000
1250	-0.503	-0.500	-0.003
1600	-1.513	-1.510	-0.003
2000	-2.778	-2.780	0.002
2500	-4.316	-4.320	0.004
3150	-6.166	-6.170	0.004
4000	-8.322	-8.330	0.008
5000	-10.573	-10.590	0.017
6300	-13.178	-13.200	0.022
8000	-16.241	-16.270	0.029
10000	-19.495	-19.520	0.025

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 10 of 42

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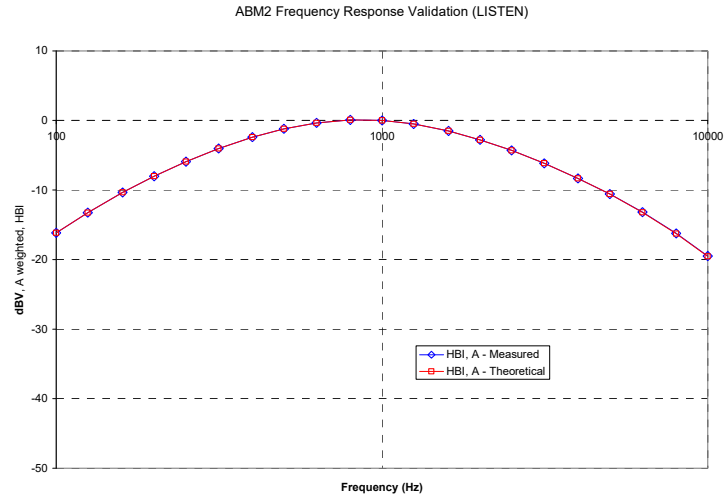


Figure 4-8
ABM2 Frequency Response Validation

The ABM2 result is a power sum from 100Hz to 10kHz with half-band integration and A-weighting. To verify the power sum measurement, a power sum over the full band was measured and verified to track with the source level (See Figure 4-9). Therefore the setup in this step was used to verify the power sum post-processing for ABM2 measurements. See below block diagram:

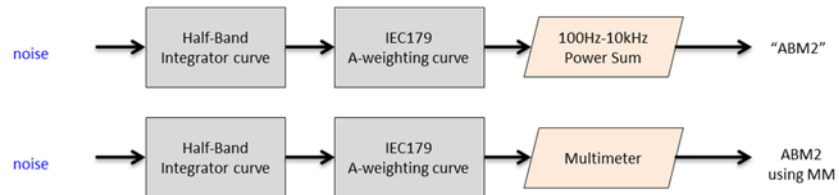


Figure 4-9
ABM2 Validation Block Diagram

The power summed output results for a known input were compared to the multi-meter results to verify any deviation in the post-processing implemented with the power-sum.

Table 4-2
ABM2 Power Sum Validation

WN Input (dBV)	Power Sum (dBV)	Multimeter-Full (dBV)	Dev (dB)
-60	-60.36	-60.2	0.16
-50	-50.19	-50.13	0.06
-40	-40.14	-40.03	0.11
-30	-30.13	-30.01	0.12
-20	-20.12	-20	0.12
-10	-10.14	-10	0.14

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 11 of 42

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04/17/2018

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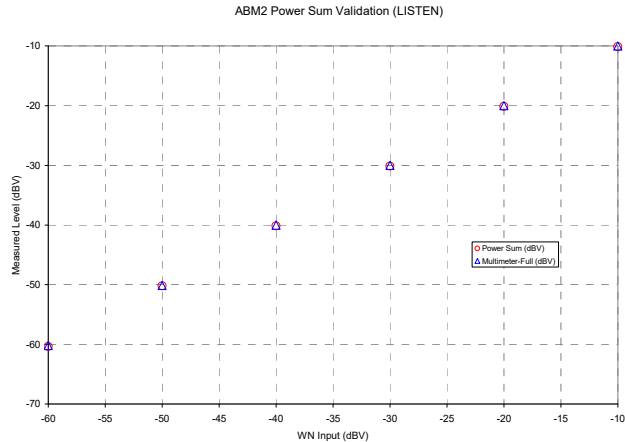


Figure 4-10
ABM2 Power Sum Validation

3. Measurement Test Setup

a. Fine scan above the WD (TEM)

- i. A multitone signal was applied to the handset such that the phone acoustic output was stable within 1dB over the probe settling time and with the acoustic output level at the C63.19 specified levels (below). The measurement step size was in 2 mm increments at a distance of 10 mm between the surface of the wireless device as shown below (note that in Figure 4-12, the grid is not to scale but merely a graphical representation of the coordinate system in use):

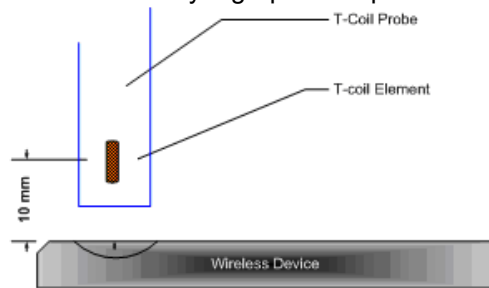


Figure 4-11
Measurement Distance

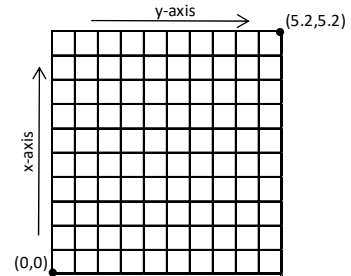


Figure 4-12
Measurement Grid

- ii. After scanning, the planar field maximum point was determined. The position of the probe was moved to this location to setup the test using the SoundCheck system.
 - iii. These steps were repeated for all T-coil orientations (axial and radial) per Figure 4-14 after a T-coil orientation was fully measured with the SoundCheck system.
- #### b. Speech Signal Setup to Base Station Simulator
- i. C63.19 Table 7-1 states audio reference input levels for various technologies:

Standard	Technology	Input Level (dBm0)
TIA/EIA/IS-2000	CDMA	-18
J-STD-007	GSM (217)	-16
T1/T1P1/3GPP	UMTS (WCDMA)	-16
IDEN™	TDMA (22 and 11 Hz)	-18

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 12 of 42

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- c. Real-Time Analyzer (RTA)
 - i. The Real-Time Analyzer was configured to analyze measurements using 1/3 Octave band weighted filtering.
 - d. WD Radio Configuration Selection
 - i. The device was chosen to be tested in the worst-case ABM2 condition.
4. Signal Quality Data Analysis
- a. Narrow-band Magnetic Intensity
 - i. The standard specifies a 1kHz 1/3 octave band minimum field intensity for a sine tone. The ABM1 measurements were evaluated at 1kHz with 1/3 octave band filtering over an averaged period of 10 seconds.
 - b. Frequency Response
 - i. The appropriate frequency response curve was measured to curves in Figure 3-1 or Figure 3-2 between 300 – 3000 Hz using digital linear averaging (limit lines chosen according to measurement found in step 4a). A linear average over 3x the length of the artificial voice signal (3x sampling) was performed. A 10 second delay was configured in the measurement process of the stimulus to ensure handset vocoder latency effects and echo cancellation devices (if any) were appropriately stabilized during measurements.
 - ii. The appropriate post-processing was applied according to the system processing chain illustrated in Figure 4-7. All R10 frequencies were plotted with respect to 0dB at 1kHz value and aligned with respect to the EIA-504 mask.
 - iii. The margin is represented by the closest measured data point on the curve to the EIA-504 limit lines, in dB.
 - c. Signal Quality Index
 - i. Ensuring the WD was at maximum RF power, maximum volume, backlight off, display on, maximum contrast setting, keypad lights on (when possible) with no audio signal through the vocoder, the WD was measured over at least 100 Hz – 10,000 Hz, maximized over 5 seconds with a 50ms sample time for the ABM2 measurement (5 second time period is used in noise measurements under standards such as IEEE 269, etc.).
 - ii. After applying half-band integration and A-weighting to the result, a power sum was applied over each 1/3 octave bandwidth frequency for an ABM2 value.
 - iii. This result was subtracted from the ABM1 result in step a, to obtain the Signal Quality.

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 13 of 42

V. Test Setup

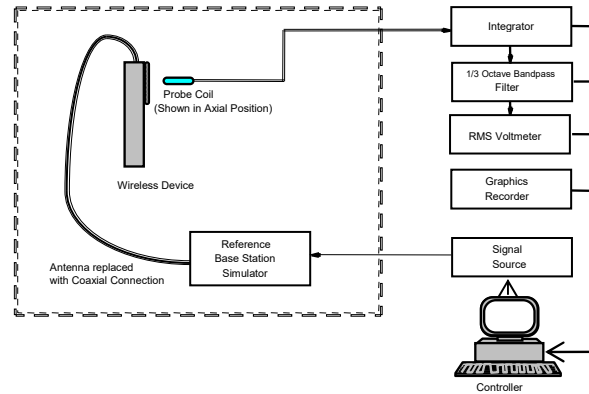


Figure 4-13
Audio Magnetic Field Test Setup

VI. Deviation from C63.19 Test Procedure

Non-conducted RF connection due to inaccessible RF ports.

VII. Air Interface Technologies Tested

All air interfaces which support voice capabilities over a managed CMRS or pre-installed OTT VoIP applications were tested for T-coil unless otherwise noted. See Table 2-1 for more details regarding which modes were tested.

VIII. Wireless Device Channels and Frequencies

1. 4G (LTE) Modes

The middle channel for every band and bandwidth combination was tested for each probe orientation. The band and bandwidth combination from each probe orientation resulting in the worst-case SNNR was additionally tested using low and high channels for that band and bandwidth combination. The middle channel and supported bandwidths from the worst-case band according to Table 5-1 was additionally evaluated with OTT VoIP for each probe orientation. See Tables 6-2 to 6-4 for LTE bandwidths and channels.

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 14 of 42

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04/17/2018

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IX. Test Flow

The flow diagram below was followed (From C63.19):

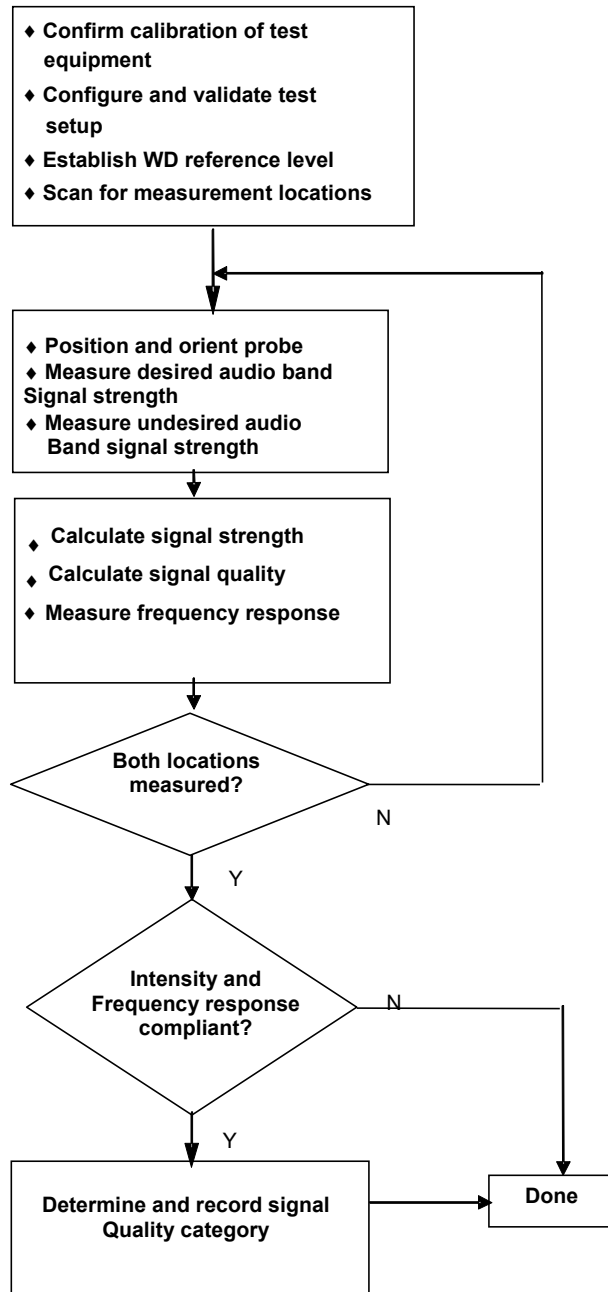


Figure 4-14
C63.19 T-Coil Signal Test Process

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 15 of 42

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REV 3.2.M

04/17/2018

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5. OTT VOIP TEST SYSTEM AND DUT CONFIGURATION

I. Test System Setup for OTT VoIP T-Coil Testing

1. OTT VoIP Application

Google Duo is a pre-installed application on the DUT which allows for VoIP calls in a held-to-ear scenario. Duo uses the OPUS audio codec and supports a bitrate range of 6kb/s to 64kb/s. All air interfaces capable of a data connection were evaluated with Google Duo.

2. Equipment Setup

A CMW500 callbox was used to perform OTT VoIP T-coil measurements. The Data Application Unit (DAU) of the CMW500 was connected to the internet and allowed for an IP data connection on the DUT. An auxiliary VoIP unit was used to initiate an OTT VoIP call to the DUT. The auxiliary VoIP unit allowed for the configuration and monitoring of the OTT VoIP codec bitrate during a call. Both high and low bitrate settings were evaluated in to determine the worst-case configuration.

3. Audio Level Settings

According to KDB 285076 D02, the average speech level of -20dBm0 shall be used for protocols not specifically listed in Table 7.1 of ANSI C63.19-2011 or the ANSI C63.19-2011 VoLTE interpretation². The auxiliary VoIP unit allowed for monitoring the signal input level to ensure that the settings for speech input and full scale levels resulted in the -20dBm0 speech input level to the DUT for the OTT VoIP call.

II. DUT Configuration for OTT VoIP T-Coil Testing

1. Radio Configuration for OTT VoIP (LTE)

An investigation was performed to determine the worst-case LTE band to be used for OTT VoIP testing. LTE Band 26 was used for the testing as the worst-case configuration for the handset. See below table for SNNR comparison between different LTE bands:

Table 5-1
OTT VoIP (LTE) SNNR by LTE Band

Band	Frequency [MHz]	Channel	Bandwidth [MHz]	Modulation	RB Size	RB Offset	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	SNNR [dB]
25	1882.5	26365	20	16QAM	1	0	7.02	-27.18	34.20
26	831.5	26865	15	16QAM	1	0	6.75	-26.95	33.70

² FCC Office of Engineering and Technology KDB, "285076 D02 T-Coil Testing for CMRS IP v03," September 13, 2017

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset	Page 16 of 42	

6. T-COIL TEST SUMMARY

Table 6-1
Consolidated Tabled Results

		Freq. Response Margin		Magnetic Intensity Verdict		FCC SNNR Verdict		Margin from FCC Limit (dB)	C63.19-2011 Rating
C63.19 Section		8.3.2		8.3.1		8.3.4			
		Axial	Radial	Axial	Radial	Axial	Radial		
LTE FDD	B26	PASS	NA	PASS	PASS	PASS	PASS	-6.37	T3
	B25	PASS	NA	PASS	PASS	PASS	PASS		
LTE FDD (OTT VoIP)	B26	PASS	NA	PASS	PASS	PASS	PASS	-14.00	T4

I. Raw Handset Data

Table 6-2
Raw Data Results for LTE B26

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 26	Axial	15MHz	26865	0.33	-29.23	-63.92	1.27	29.56	20.00	-9.56	T3	2.8, 2.6
		10MHz	26865	0.50	-29.09		1.31	29.59	20.00	-9.59	T3	
		5MHz	26865	0.25	-29.79		1.20	30.04	20.00	-10.04	T4	
		3MHz	26865	0.29	-30.11		1.21	30.40	20.00	-10.40	T4	
		1.4MHz	26865	0.64	-30.02		1.25	30.66	20.00	-10.66	T4	
	Radial	15MHz	26865	-9.16	-35.78	-64.07	N/A	26.62	20.00	-6.62	T3	2.8, 2.2
		10MHz	26865	-9.62	-37.31			27.69	20.00	-7.69	T3	
		5MHz	26865	-9.40	-36.78			27.38	20.00	-7.38	T3	
		3MHz	26865	-9.54	-37.03			27.49	20.00	-7.49	T3	
		1.4MHz	26865	-9.69	-36.40			26.71	20.00	-6.71	T3	

Table 6-3
Raw Data Results for LTE B25

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 25	Axial	20MHz	26590	0.13	-29.14	-63.92	1.38	29.27	20.00	-9.27	T3	2.8, 2.6
		20MHz	26365	-0.16	-29.65		1.32	29.49	20.00	-9.49	T3	
		20MHz	26140	-0.10	-29.38		1.38	29.28	20.00	-9.28	T3	
		15MHz	26365	0.38	-29.33		1.30	29.71	20.00	-9.71	T3	
		10MHz	26365	0.11	-30.19		1.35	30.30	20.00	-10.30	T4	
		5MHz	26365	-0.15	-29.92		1.35	29.77	20.00	-9.77	T3	
		3MHz	26365	0.16	-30.01		1.32	30.17	20.00	-10.17	T4	
		1.4MHz	26365	-0.17	-30.22		1.28	30.05	20.00	-10.05	T4	
	Radial	20MHz	26365	-9.55	-36.17	-64.07	N/A	26.62	20.00	-6.62	T3	2.8, 2.2
		15MHz	26365	-9.66	-37.07			27.41	20.00	-7.41	T3	
		10MHz	26640	-9.24	-36.26			27.02	20.00	-7.02	T3	
		10MHz	26365	-9.78	-36.15			26.37	20.00	-6.37	T3	
		10MHz	26090	-9.26	-36.60			27.34	20.00	-7.34	T3	
		5MHz	26365	-9.59	-36.41			26.82	20.00	-6.82	T3	
		3MHz	26365	-9.09	-35.81			26.72	20.00	-6.72	T3	
		1.4MHz	26365	-9.11	-36.36			27.25	20.00	-7.25	T3	

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 17 of 42

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04/17/2018

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Table 6-4
Raw Data Results for LTE B26 (OTT VoIP)

Mode	Orientation	Bandwidth	Channel	ABM1 [dB(A/m)]	ABM2 [dB(A/m)]	Ambient Noise [dB(A/m)]	Frequency Response Margin (dB)	S+N/N (dB)	FCC Limit (dB)	Margin from FCC Limit (dB)	C63.19-2011 Rating	Test Coordinates
LTE Band 26	Axial	15MHz	26965	7.63	-29.18	-63.92	1.07	36.81	20.00	-16.81	T4	2.8, 2.6
		15MHz	26865	7.69	-28.72		1.07	36.41	20.00	-16.41	T4	
		15MHz	26765	7.33	-28.98		1.11	36.31	20.00	-16.31	T4	
		10MHz	26865	7.78	-28.91		1.12	36.69	20.00	-16.69	T4	
		5MHz	26865	7.62	-29.29		1.09	36.91	20.00	-16.91	T4	
		3MHz	26865	7.42	-30.33		1.00	37.75	20.00	-17.75	T4	
		1.4MHz	26865	7.63	-30.65		1.19	38.28	20.00	-18.28	T4	
	Radial	15MHz	26965	-0.99	-35.77	-64.07	N/A	34.78	20.00	-14.78	T4	2.8, 2.2
		15MHz	26865	-1.11	-35.11			34.00	20.00	-14.00	T4	
		15MHz	26765	-1.04	-35.45			34.41	20.00	-14.41	T4	
		10MHz	26865	-0.90	-35.00			34.10	20.00	-14.10	T4	
		5MHz	26865	-0.82	-35.03			34.21	20.00	-14.21	T4	
		3MHz	26865	-0.96	-35.28			34.32	20.00	-14.32	T4	
		1.4MHz	26865	-0.73	-35.47			34.74	20.00	-14.74	T4	

II. Test Notes

A. General

1. Phone Condition: Mute on; Backlight off; Max Volume; Max Contrast
2. 'Radial' orientation refers to radial transverse.
3. Hearing Aid Mode (**Phone→Call Settings→Additional Settings→Hearing aids**) was set to ON for Frequency Response compliance
4. Speech Signal: ITU-T P.50 Artificial Voice
5. Bluetooth and WIFI were disabled for 4G modes while testing.
6. The Margin from FCC limit column indicates a margin from the FCC limit for compliance (T3).
7. For each tested air interface mode, the test configuration was determined by the worst-case configuration in the Original Certification Test Report (T-Coil Test Report SN: 1M1802060016 - 10.ZNF). Please see that test report for more information on the chosen configuration.

B. LTE FDD

1. Power Configuration: TPC = "Max Power"
2. Radio Configuration: 16QAM, 1RB, 0RB offset
3. Vocoder Configuration: WB AMR 6.60kbps
4. The worst-case band and bandwidth combination for each probe orientation is additionally tested on the low and high channels for those combinations. LTE Band 25 at 20MHz is the worst-case for the Axial probe orientation. LTE Band 25 at 10MHz bandwidth is the worst-case for the Radial probe orientation.

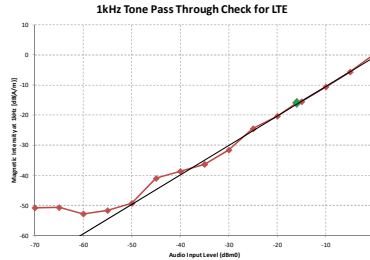
C. OTT VoIP

1. Vocoder Configuration: 6kbps
2. LTE FDD Configuration:
 - a. Power Configuration: TPC = "Max Power"
 - b. Radio Configuration: 16QAM, 1RB, 0RB offset
 - c. LTE Band 26 was the worst-case band from Table 5-1 and was used to test both Axial and Radial probe orientations.
 - d. The worst-case band and bandwidth combination for each probe orientation is additionally tested on the low and high channels for those combinations. LTE Band 26 at

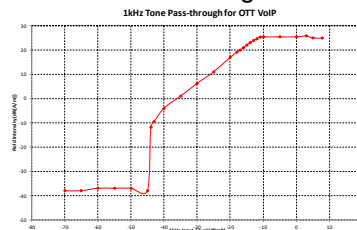
FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 18 of 42

15MHz is the worst-case for the Axial probe orientation. LTE Band 26 at 15MHz bandwidth is the worst-case for the Radial probe orientation.

III. 1 kHz Vocoder Application Check



This model was verified to be within the linear region for ABM1 measurements at -16 dBm0 for VoLTE over IMS. This measurement was taken in the axial configuration above the maximum location.



This model was verified to be within the linear region for ABM1 measurements at -20 dBm0 for OTT VoIP. This measurement was taken in the axial configuration above the maximum location.

IV. T-Coil Validation Test Results

Table 6-5
Helmholtz Coil Validation Table of Results

Item	Target	Result	Verdict
Axial			
Magnetic Intensity, -10 dBA/m	$-10 \pm 0.5 \text{ dB}$	-10.165	PASS
Environmental Noise	< -58 dBA/m	-63.92	PASS
Frequency Response, from limits	> 0 dB	0.70	PASS
Radial			
Magnetic Intensity, -10 dBA/m	$-10 \pm 0.5 \text{ dB}$	-10.291	PASS
Environmental Noise	< -58 dBA/m	-64.07	PASS
Frequency Response, from limits	> 0 dB	0.70	PASS

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Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 19 of 42

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V. ABM1 Magnetic Field Distribution Scan Overlays

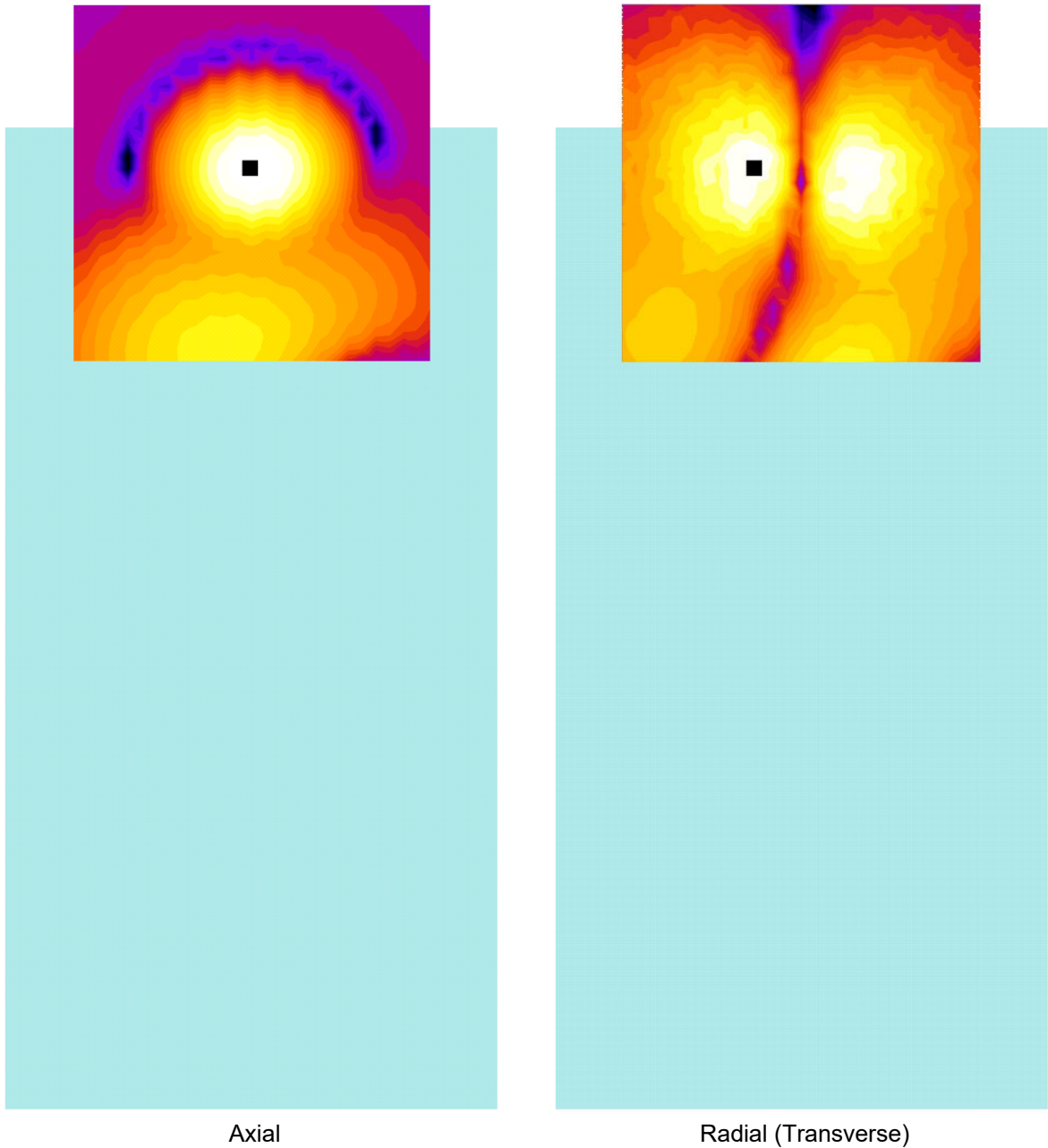


Figure 6-1
T-Coil Scan Overlay Magnetic Field Distributions

Notes:

1. Final measurement locations are indicated by a cursor on the contour plots.
2. See Test Setup Photographs for actual WD overlay.

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 20 of 42

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7. MEASUREMENT UNCERTAINTY

Table 7-1
Uncertainty Estimation Table

Contribution	Data +/- %	Data +/- dB	Data Type	Probability distribution	Divisor	Standard uncertainty	Standard Uncertainty (dB)
ABM Noise	7.0%	0.29	Std. Dev.	Normal k=1	1.00	7.0%	
RF Reflections	4.7%	0.20	Specification	Rectangular	1.73	2.7%	
Reference Signal Level	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Positioning Accuracy	10.0%	0.41	Uncertainty	Rectangular	1.73	5.8%	
Probe Coil Sensitivity	12.2%	0.50	Specification	Rectangular	1.73	7.0%	
Probe Linearity	2.4%	0.10	Std. Dev.	Normal k=1	1.00	2.4%	
Cable Loss	2.8%	0.12	Specification	Rectangular	1.73	1.6%	
Frequency Analyzer	5.0%	0.21	Specification	Rectangular	1.73	2.9%	
System Repeatability	5.0%	0.21	Std. Dev.	Normal k=1	1.00	5.0%	
WD Repeatability	9.0%	0.37	Std. Dev.	Normal k=1	1.00	9.0%	
Positioner Accuracy	1.0%	0.04	Specification	Rectangular	1.73	0.6%	
Combined standard uncertainty, u_c (k=1)						17.7%	0.71
Expanded uncertainty (k=2), 95% confidence level						35.3%	1.31

Notes:

1. Test equipments are calibrated according to techniques outlined in NIS81, NIS3003 and NIST Tech Note 1297.
2. All equipments have traceability according to NIST. Measurement Uncertainties are defined in further detail in NIS 81 and NIST Tech Note 1297 and UKAS M3003.

Measurement uncertainty reflects the quality and accuracy of a measured result as compared to the true value. Such statements are generally required when stating results of measurements so that it is clear to the intended audience that the results may differ when reproduced by different facilities. Measurement results vary due to the measurement uncertainty of the instrumentation, measurement technique, and test engineer. Most uncertainties are calculated using the tolerances of the instrumentation used in the measurement, the measurement setup variability, and the technique used in performing the test. While not generally included, the variability of the equipment under test also figures into the overall measurement uncertainty. Another component of the overall uncertainty is based on the variability of repeated measurements (so-called Type A uncertainty). This may mean that the Hearing Aid compatibility tests may have to be repeated by taking down the test setup and resetting it up so that there are a statistically significant number of repeat measurements to identify the measurement uncertainty. By combining the repeat measurement results with that of the instrumentation chain using the technique contained in NIS 81 and NIS 3003, the overall measurement uncertainty was estimated.

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 21 of 42

8. EQUIPMENT LIST

**Table 8-1
Equipment List**

Manufacturer	Model	Description	Cal Date	Cal Interval	Cal Due	Serial Number
Dell	Latitude E6540	SoundCheck Acoustic Analyzer Laptop	4/11/2017	Biennial	4/11/2019	7BFNM32
Listen	SoundConnect	Microphone Power Supply	12/2/2016	Biennial	12/2/2018	PS2612
RME	Fireface UC	Soundcheck Acoustic Analyzer External Audio Interface	4/11/2017	Biennial	4/11/2019	23528889
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	1/19/2018	Annual	1/19/2019	162125
Rohde & Schwarz	CMW500	Wideband Radio Communication Tester	8/3/2018	Annual	8/3/2019	140144
Seekonk	NC-100	Torque Wrench (8" lb)	5/10/2018	Biennial	5/10/2020	21053
TEM	C63.19	Helmholtz Coil	12/7/2016	Biennial	12/7/2018	925
TEM	Radial T-Coil Probe	Radial T-Coil Probe	12/7/2016	Biennial	12/7/2018	TEM-1130
TEM	Axial T-Coil Probe	Axial T-Coil Probe	12/7/2016	Biennial	12/7/2018	TEM-1124
TEM		HAC System Controller with Software	N/A		N/A	N/A
TEM		HAC Positioner	N/A		N/A	N/A

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 22 of 42

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9. TEST DATA

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 23 of 42

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PCTEST Hearing-Aid Compatibility Facility

DUT: HH Coil – SN: 925

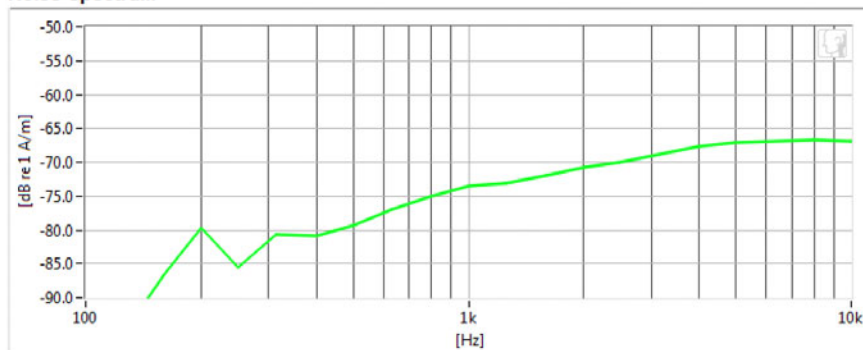
Type: HH Coil
Serial: 925

Measurement Standard: ANSI C63.19-2011

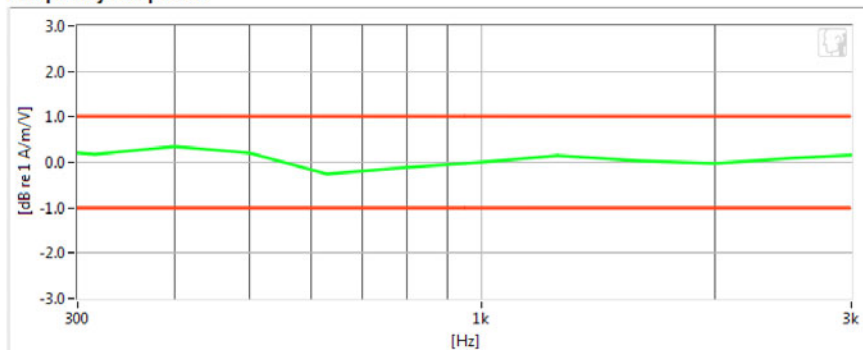
Equipment:

- Probe: Axial T-Coil Probe – SN: TEM-1124; Calibrated: 12/07/2016
- Helmholtz Coil – SN: 925; Calibrated: 12/07/2016

Noise Spectrum



Frequency Response



Results

Verification 1kHz Intensity	-10.165 dB	✓	Max/Min	-9.5/-10.5
Verification ABM2	-63.92 dB	✓	Maximum	-58.0
Frequency Response Margin	700m dB	✓	Tolerance curves	Aligned Data

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FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 24 of 42

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PCTEST Hearing-Aid Compatibility Facility

DUT: HH Coil – SN: 925

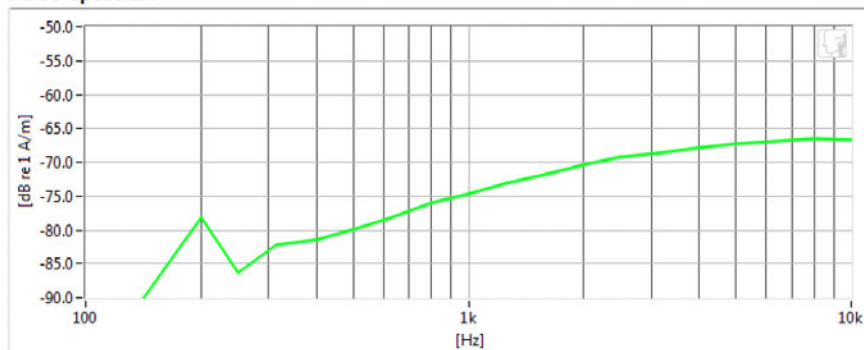
Type: HH Coil
Serial: 925

Measurement Standard: ANSI C63.19-2011

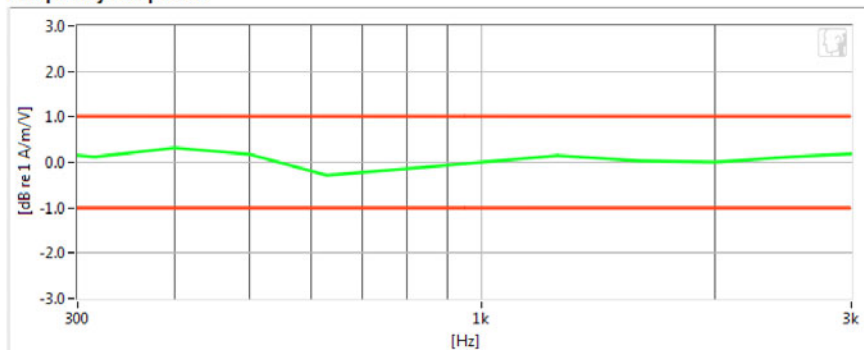
Equipment:

- Probe: Radial T-Coil Probe – SN: TEM-1130; Calibrated: 12/07/2016
- Helmholtz Coil – SN: 925; Calibrated: 12/07/2016

Noise Spectrum



Frequency Response



Results

Verification 1kHz Intensity	-10.291 dB	✓	Max/Min	-9.5/-10.5
Verification ABM2	-64.07 dB	✓	Maximum	-58.0
Frequency Response Margin	700m dB	✓	Tolerance curves	Aligned Data

PCTEST 2018

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 25 of 42

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PCTEST Hearing-Aid Compatibility Facility

DUT: ZNFX212TA

Type: Portable Handset

Serial: 02819

Measurement Standard: ANSI C63.19-2011

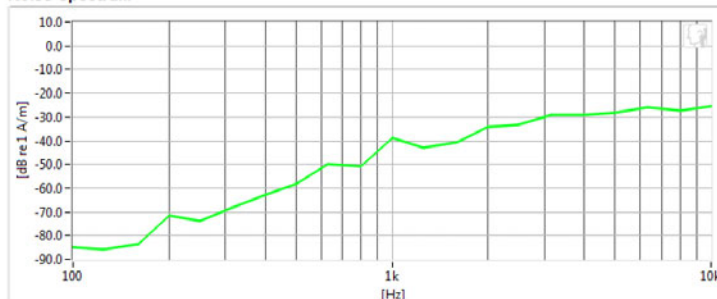
Equipment:

- Probe: Axial T-Coil Probe – SN: TEM-1124; Calibrated: 12/07/2016

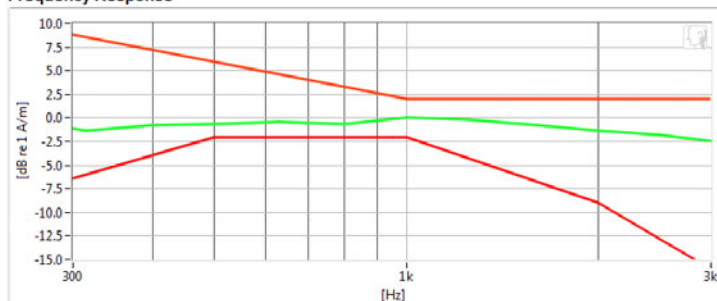
Test Configuration:

- Mode: LTE FDD Band 25
- Bandwidth: 20MHz
- Channel: 26590
- Speech Signal: ITU-T P.50 Artificial Voice

Noise Spectrum



Frequency Response



Results

ABM1	130m dB	✓	Minimum	-18.0
ABM2	-29.14 dB	✓	Maximum	0
SNNR	29.27 dB	✓	Minimum	20
Aligned Response - P.50	1.38 dB	✓	Tolerance curves	Aligned Data

PCTEST 2018

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 26 of 42

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PCTEST Hearing-Aid Compatibility Facility

DUT: ZNFX212TA

Type: Portable Handset

Serial: 02819

Measurement Standard: ANSI C63.19-2011

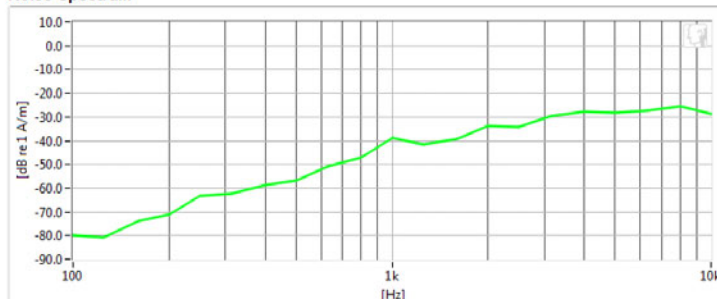
Equipment:

- Probe: Axial T-Coil Probe – SN: TEM-1124; Calibrated: 12/07/2016

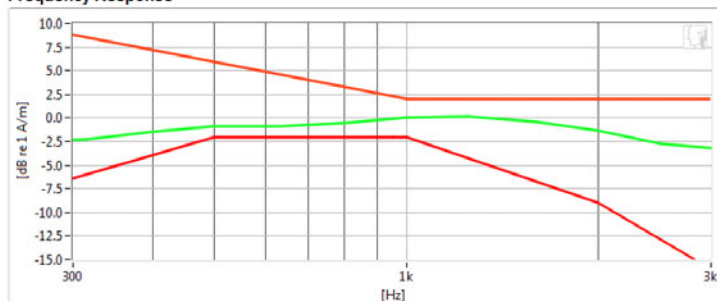
Test Configuration:

- VoIP Application: Google Duo
- Mode: LTE FDD Band 26
- Bandwidth: 15MHz
- Channel: 26765
- Speech Signal: ITU-T P.50 Artificial Voice

Noise Spectrum



Frequency Response



Results

ABM1	7.33 dB	✓	Minimum	-18.0
ABM2	-28.97 dB	✓	Maximum	0
SNNR	36.31 dB	✓	Minimum	20
Aligned Response - P.50	1.11 dB	✓	Tolerance curves	Aligned Data

PCTEST 2018

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 27 of 42

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PCTEST Hearing-Aid Compatibility Facility

DUT: ZNFX212TA

Type: Portable Handset
Serial: 02819

Measurement Standard: ANSI C63.19-2011

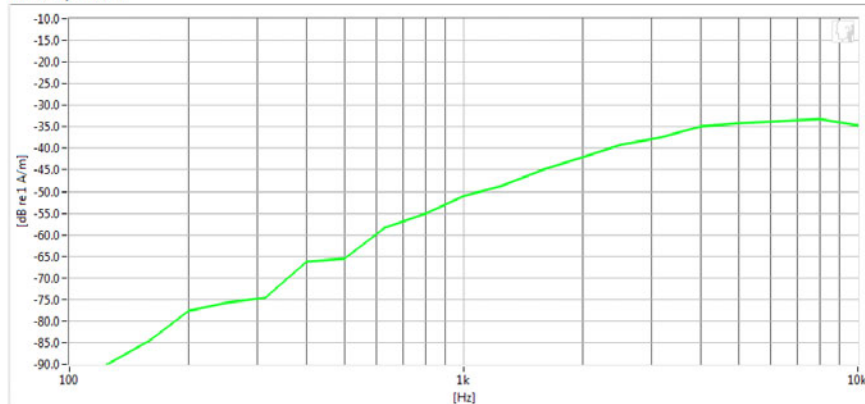
Equipment:

- Probe: Radial T-Coil Probe – SN: TEM-1130; Calibrated: 12/07/2016

Test Configuration:

- Mode: LTE FDD Band 25
- Bandwidth: 10MHz
- Channel: 26365

Noise Spectrum



Results

ABM1	-9.78 dB	✓	Minimum	-18.0
ABM2	-36.15 dB	✓	Maximum	0.0
SNNR	26.37 dB	✓	Minimum	20.0

PCTEST 2018

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset	Page 28 of 42	

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PCTEST Hearing-Aid Compatibility Facility

DUT: ZNFX212TA

Type: Portable Handset
Serial: 02819

Measurement Standard: ANSI C63.19-2011

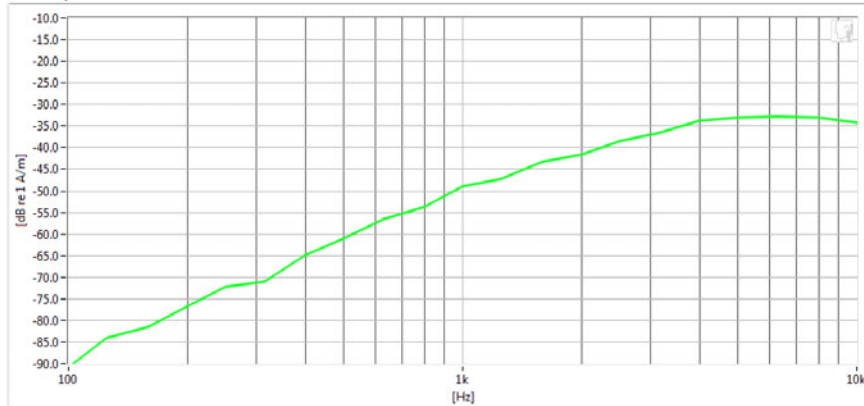
Equipment:

- Probe: Radial T-Coil Probe – SN: TEM-1130; Calibrated: 12/07/2016

Test Configuration:

- VoIP Application: Google Duo
- Mode: LTE FDD Band 26
- Bandwidth: 15MHz
- Channel: 26865

Noise Spectrum



Results

ABM1	-1.11 dB	✓	Minimum	-18.0
ABM2	-35.11 dB	✓	Maximum	0.0
SNNR	34 dB	✓	Minimum	20.0

PCTEST 2018

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset	Page 29 of 42	

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10. CALIBRATION CERTIFICATES

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset	Page 30 of 42	

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West Caldwell Calibration Laboratories Inc.

Certificate of Calibration

for

AXIAL T COIL PROBE

Manufactured by: TEM CONSULTING
Model No: AXIAL T COIL PROBE
Serial No: TEM-1124
Calibration Recall No: 27068

Submitted By:

Customer: ANDREW HARWELL
Company: PCTEST ENGINEERING LAB
Address: 6660-B DOBBIN ROAD
COLUMBIA MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No. AXIAL T C TEM C

Upon receipt for Calibration, the instrument was found to be:

Within (X)

tolerance of the indicated specification. See attached Report of Calibration.

West Caldwell Calibration Laboratories' calibration control system meets the following requirements, ISO 10012-1 MIL STD 45662A, ANSI/NC SL Z540-1, IEC Guide 25, ISO 9001:2008 and ISO 17025

Note: With this Certificate, Report of Calibration is Included.

Approved by:

Calibration Date: 07-Dec-16

Certificate No: 27068 -3

QA Doc. #1081 Rev. 2.0 10/1/01

Certificate Page 1 of 1

Felix Christopher (QA Mgr.)

ISO/IEC 17025:2005

West Caldwell
Calibration
Laboratories, Inc.
uncompromised calibration
1575 State Route 96, Victor, NY 14564, U.S.A.



Calibration Lab. Cert. # 1533.01

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 31 of 42

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REPORT OF CALIBRATION

TEM Consulting LP Axial T Coil Probe

for
Model No.: Axial T Coil Probe

Serial No.: TEM 1124

Company : PCTEST Engineering Lab.

I. D. No: 80578

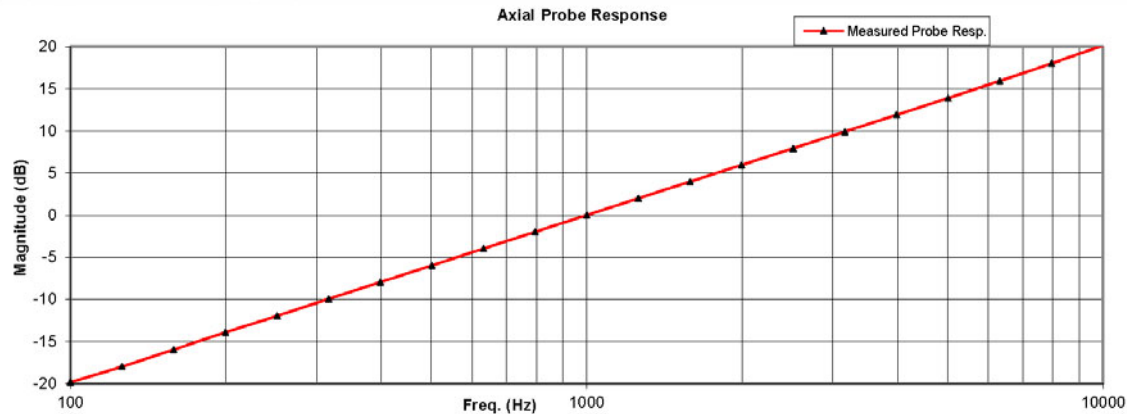
Calibration results:			
Probe Sensitivity measured with Helmholtz Coil			
Helmholtz Coil;			
the number of turns on each coil;	10	No.	
the radius of each coil, in meters;	0.204	m	
the current in the coils, in amperes;	0.09	A	
Helmholtz Coil Constant;	7.09	A/m/V	
Helmholtz Coil magnetic field;	5.98	A/m	
Before & after data same: ... X.....			
Laboratory Environment:			
Ambient Temperature:	20.2	°C	
Ambient Humidity:	31.4	% RH	
Ambient Pressure:	99.1	kPa	
Calibration Date:	7-Dec-16		
Probe Sensitivity at	1000	Hz.	
was	-60.23	dBV/A/m	
	0.974	mV/A/m	
Probe resistance	904	Ohms	
Report Number:	27068	-3	
Control Number:	27068		

The above listed instrument meets or exceeds the tested manufacturer's specifications.

This Calibration is traceable through NIST test numbers: 683/284413-14

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCCL Z540-1, (MIL-STD-45662A) and ISO 9001:2008, ISO 17025

Cal. Date: 7-Dec-2016

Measurements performed by: FC

Calibrated on WCCL system type 9700

Felix Christopher

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Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

FCC ID: ZNFX212TA	PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	LG	Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 32 of 42

HCATEMC_TEM 1124_Dec-07-2016

West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564
Tel. (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Axial T Coil Probe

Model No.: Axial T Coil Probe

Serial No.: TEM 1124

Company : PCTEST Engineering Lab.

Test	Function	Tolerance	Measured values		
			Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz. μ BV/A/m	-60.23		
2.0	Probe Level Linearity	μ B			
		6	6.03		
		0	0.00		
		-6	-6.03		
		-12	-12.05		
3.0	Probe Frequency Response	Hz			
		100	-19.8		
		126	-18.0		
		158	-16.0		
		200	-13.9		
		251	-12.0		
		316	-9.9		
		398	-8.0		
		501	-6.0		
		631	-4.0		
		794	-2.0		
		1000	0.0		
		1259	2.0		
		1585	4.0		
		1995	6.0		
		2512	7.9		
		3162	9.9		
		3981	11.9		
		5012	13.9		
		6310	15.9		
		7943	18.0		
		10000	20.2		

Instruments used for calibration:				Date or Cal.	Traceability No.	Due Date
HP	34401A	S/N	36064102	1-Oct-2016	,287708	1-Oct-2017
HP	34401A	S/N	36102471	1-Oct-2016	,287708	1-Oct-2017
HP	33120A	S/N	36043716	1-Oct-2016	,287708	1-Oct-2017
B&K	2133	S/N	1583254	1-Oct-2016	683/284413-14	1-Oct-2017

Cal. Date: 7-Dec-2016

Tested by: Felix Christopher

Calibrated on WCCL system type 9700

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Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCATEMC

Page 2 of 2

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 33 of 42

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West Caldwell Calibration Laboratories Inc.

Certificate of Calibration

for

RADIAL T COIL PROBE

Manufactured by: TEM CONSULTING
Model No: RADIAL T COIL PROBE
Serial No: TEM-1130
Calibration Recall No: 27068

Submitted By:

Customer: ANDREW HARWELL
Company: PCTEST ENGINEERING LAB
Address: 6660-B DOBBIN ROAD
COLUMBIA MD 21045

The subject instrument was calibrated to the indicated specification using standards traceable to the National Institute of Standards and Technology or to accepted values of natural physical constants. This document certifies that the instrument met the following specification upon its return to the submitter.

West Caldwell Calibration Laboratories Procedure No. RADIAL T TEM C

Upon receipt for Calibration, the instrument was found to be:

Within (X)

tolerance of the indicated specification. See attached Report of Calibration.

West Caldwell Calibration Laboratories' calibration control system meets the following requirements, ISO 10012-1 MIL STD 45662A, ANSI/NCSL Z540-1, IEC Guide 25, ISO 9001:2008 and ISO 17025

Note: With this Certificate, Report of Calibration is included.

Approved by:

Calibration Date: 07-Dec-16

Certificate No: 27068 - 2

QA Doc. #1081 Rev. 2.0 10/1/01

Certificate Page 1 of 1

Felix Christopher (QA Mgr.)
ISO/IEC 17025:2005

West Caldwell
Calibration
Laboratories, Inc.
uncompromised calibration
1575 State Route 96, Victor, NY 14564, U.S.A.



Calibration Lab. Cert. # 1533.01

FCC ID: ZNFX212TA	 PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	 LG	Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 34 of 42

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REPORT OF CALIBRATION

TEM Consulting LP Radial T Coil Probe

for
Model No.: Radial T Coil Probe

Serial No.: TEM-1130

Company : PCTEST Engineering Lab.

I. D. No: 80579

Calibration results:

Probe Sensitivity measured with Helmholtz Coil

Helmholtz Coil;
the number of turns on each coil; 10 No.
the radius of each coil, in meters; 0.204 m
the current in the coils, in amperes; 0.09 A
Helmholtz Coil Constant; 7.09 A/m/V
Helmholtz Coil magnetic field; 5.98 A/m

Before & after data same: ... X ...

Laboratory Environment:

Ambient Temperature: 20.2 °C

Ambient Humidity: 31.4 % RH

Ambient Pressure: 99.1 kPa

Calibration Date: 7-Dec-16

Probe Sensitivity at 1000 Hz.

was -60.27 dBV/A/m

0.969 mV/A/m

Probe resistance 902 Ohms

Report Number: 27068 -2

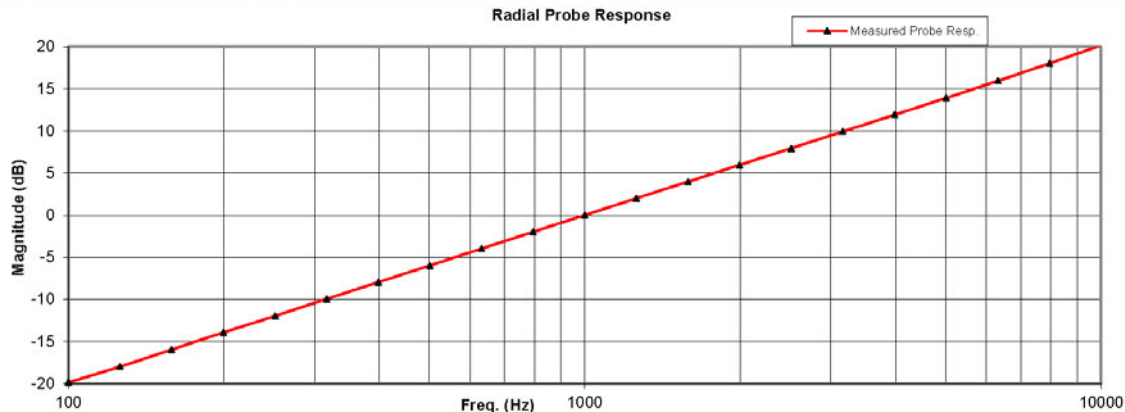
Control Number: 27068

The above listed instrument meets or exceeds the tested manufacturer's specifications.

This Calibration is traceable through NIST test numbers: 683/284413-14

The expanded uncertainty of calibration: 0.30dB at 95% confidence level with a coverage factor of k=2.

Graph represents Probes Frequency Response.



The above listed instrument was checked using calibration procedure documented in West Caldwell

Calibration Laboratories Inc. procedure :

Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

Calibration was performed by West Caldwell Calibration Laboratories Inc. under Operating Procedures

intended to implement the requirements of ISO10012-1, IEC Guide 25, ANSI/NCCL Z540-1, (MIL-STD-45662A) and ISO 9001:2008, ISO 17025

Cal. Date: 7-Dec-2016

Measurements performed by: FC

Calibrated on WCCL system type 9700

Felix Christopher

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Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

Page 1 of 2

FCC ID: ZNFX212TA	PCTEST ENGINEERING LABORATORY, INC.	HAC (T-COIL) TEST REPORT	LG	Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 35 of 42

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West Caldwell Calibration Laboratories Inc.

1575 State Route 96, Victor NY 14564
Tel: (585) 586-3900 FAX (585) 586-4327

Calibration Data Record

TEM Consulting LP Radial T Coil Probe

Model No.: Radial T Coil Probe

Serial No.: TEM-1130

Company : PCTEST Engineering Lab.

Test	Function	Tolerance	Measured values		
			Before	Out	Remarks
1.0	Probe Sensitivity at	1000 Hz. $\pm$ BV/A/m	-60.27		
2.0	Probe Level Linearity	$\pm$ B			
		6	6.03		
		0	0.00		
		-6	-6.03		
		-12	-12.06		
3.0	Probe Frequency Response	Hz			
		100	-19.9		
		126	-18.0		
		158	-16.0		
		200	-13.9		
		251	-12.0		
		316	-10.0		
		398	-8.0		
		501	-6.0		
		631	-4.0		
		794	-2.0		
		Rat. (0 $\pm$ B)	1000	0.0	
			1259	2.0	
			1585	4.0	
			1995	6.0	
			2512	7.9	
			3162	9.9	
			3981	11.9	
			5012	13.9	
			6310	15.9	
			7943	18.0	
			10000	20.2	

Instruments used for calibration:				Date or Cal.	Traceability No.	Due Date
HP	34401A	S/N	36064102	1-Oct-2016	,287708	1-Oct-2017
HP	34401A	S/N	36102471	1-Oct-2016	,287708	1-Oct-2017
HP	33120A	S/N	36043716	1-Oct-2016	,287708	1-Oct-2017
B&K	2133	S/N	1583254	1-Oct-2016	683/284413-14	1-Oct-2017

Cal. Date: 7-Dec-2016

Tested by: Felix Christopher

Calibrated on WCCL system type 9700

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Rev. 7.0 Jan. 24, 2014 Doc. # 1038 HCRTEMC

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 36 of 42

11. CONCLUSION

The measurements indicate that LTE bands 26 & 25 of the wireless communications device complies with the HAC limits specified in accordance with the ANSI C63.19 Standard and FCC WT Docket No. 01-309 RM-8658. Precise laboratory measures were taken to assure repeatability of the tests. The tested device complies with the requirements in respect to all parameters specific to the test. The test results and statements relate only to the item(s) tested.

The measurement system and techniques presented in this evaluation are proposed in the ANSI standard as a means of best approximating wireless device compatibility with a hearing-aid. The literature is under continual re-construction.

FCC ID: ZNFX212TA		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 37 of 42

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12. REFERENCES

1. ANSI C63.19-2011, American National Standard for Methods of Measurement of Compatibility between Wireless communication devices and Hearing Aids., New York, NY, IEEE, May 2011
2. FCC Office of Engineering and Technology KDB, "285076 D01 HAC Guidance v05," September 13, 2017
3. FCC Office of Engineering and Technology KDB, "285076 D02 T-Coil Testing for CMRS IP v03," September 13, 2017
4. FCC Public Notice DA 06-1215, *Wireless Telecommunications Bureau and Office of Engineering and Technology Clarify Use of Revised Wireless Phone Hearing Aid Compatibility Standard*, June 6, 2006
5. FCC 3G Review Guidance, Laboratory Division OET FCC, May/June 2006
6. Berger, H. S., "Compatibility Between Hearing Aids and Wireless Devices," Electronic Industries Forum, Boston, MA, May, 1997
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Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset		Page 38 of 42

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04/17/2018

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Filename: 1M1810290199-02-R2.ZNF	Test Dates: 10/29/2018 - 10/31/2018	DUT Type: Portable Handset	Page 39 of 42	

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04/17/2018

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